

Device Modeling Report

COMPONENTS: THYRISTOR
PART NUMBER: BT151X-500
MANUFACTURER: PHILIPS SEMICONDUCTOR



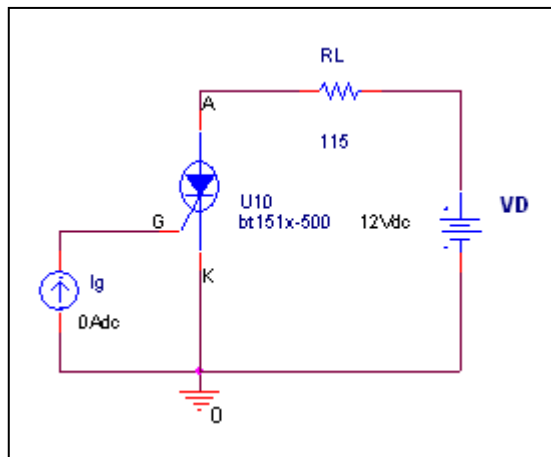
Bee Technologies Inc.

DIODE MODEL

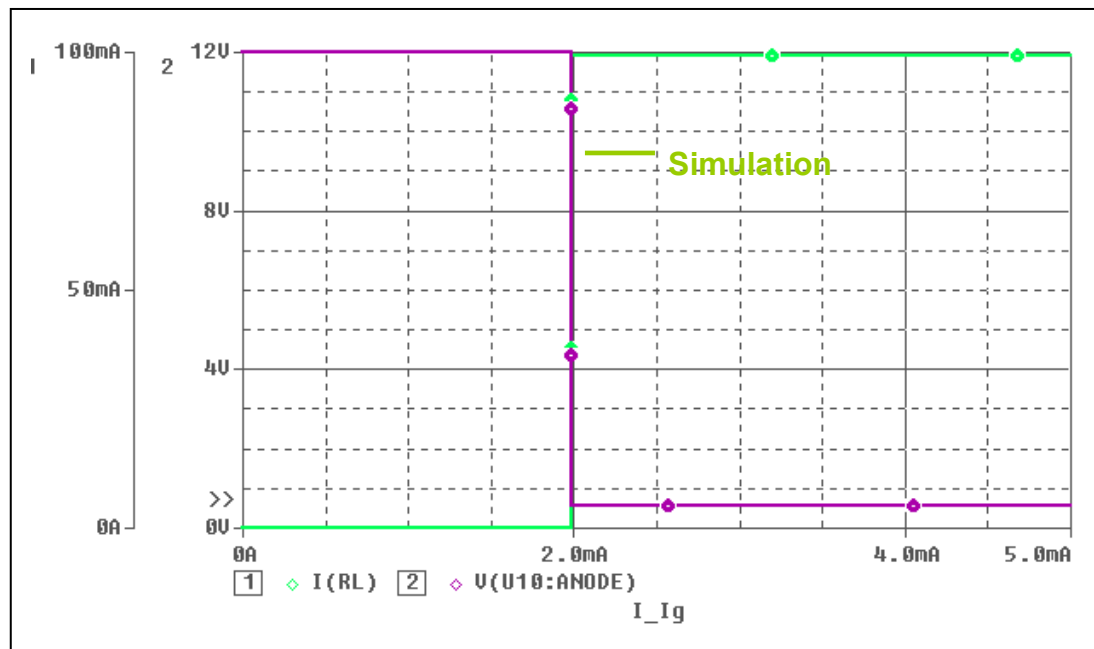
Pspice model Parameter	Model description
IS	Saturation Current
N	Emission Coefficient
RS	Series Resistance
IKF	High-injection Knee Current
CJO	Zero-bias Junction Capacitance
M	Junction Grading Coefficient
VJ	Junction Potential
ISR	Recombination Current Saturation Value
BV	Reverse Breakdown Voltage(a positive value)
IBV	Reverse Breakdown Current(a positive value)
TT	Transit Time

IG-VT Characteristic

Evaluation Circuit



Simulation result

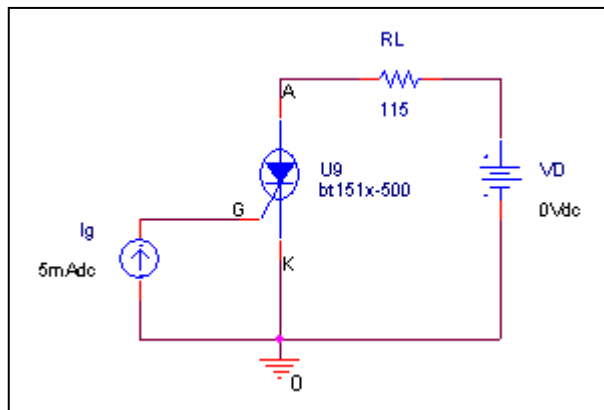


Comparison Table

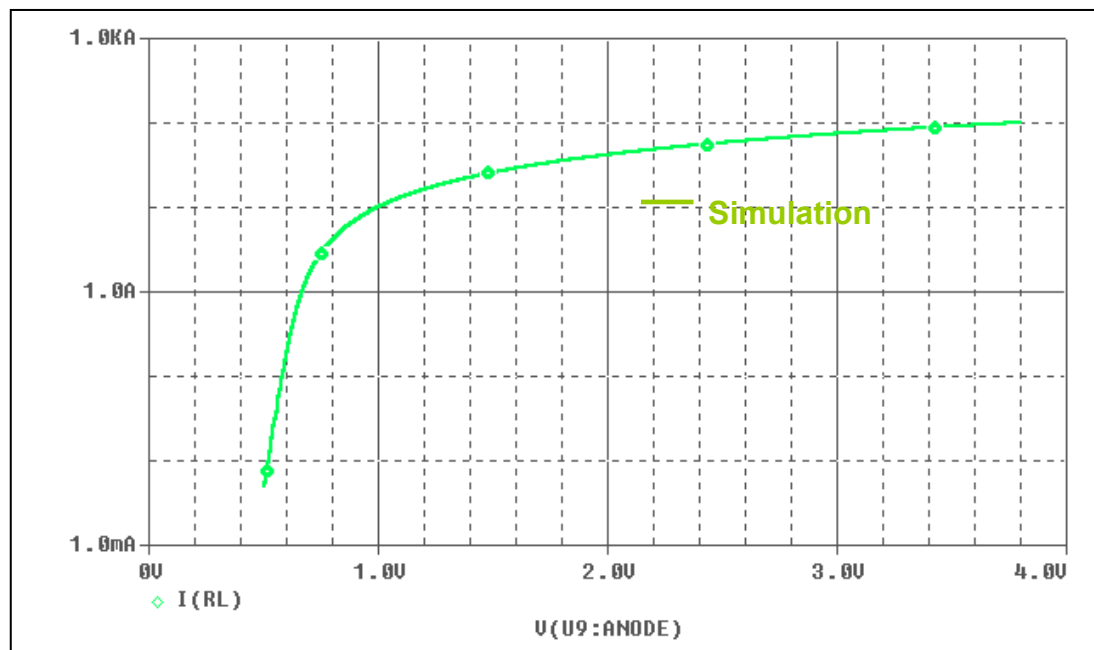
	Measurement	Simulation	% Error
I_{GT} (mA)	2	1.9834	-0.83000
V_{GT} (V)	0.6	0.582525	-2.91250

ITM-VTM Characteristic

Evaluation Circuit



Simulation result

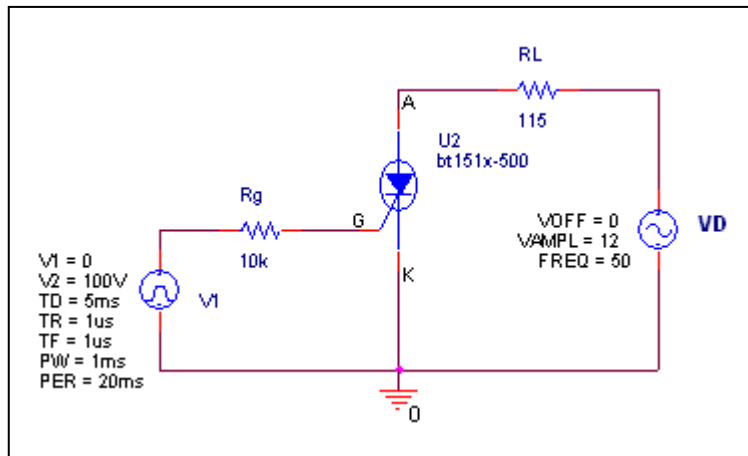


Comparison Table

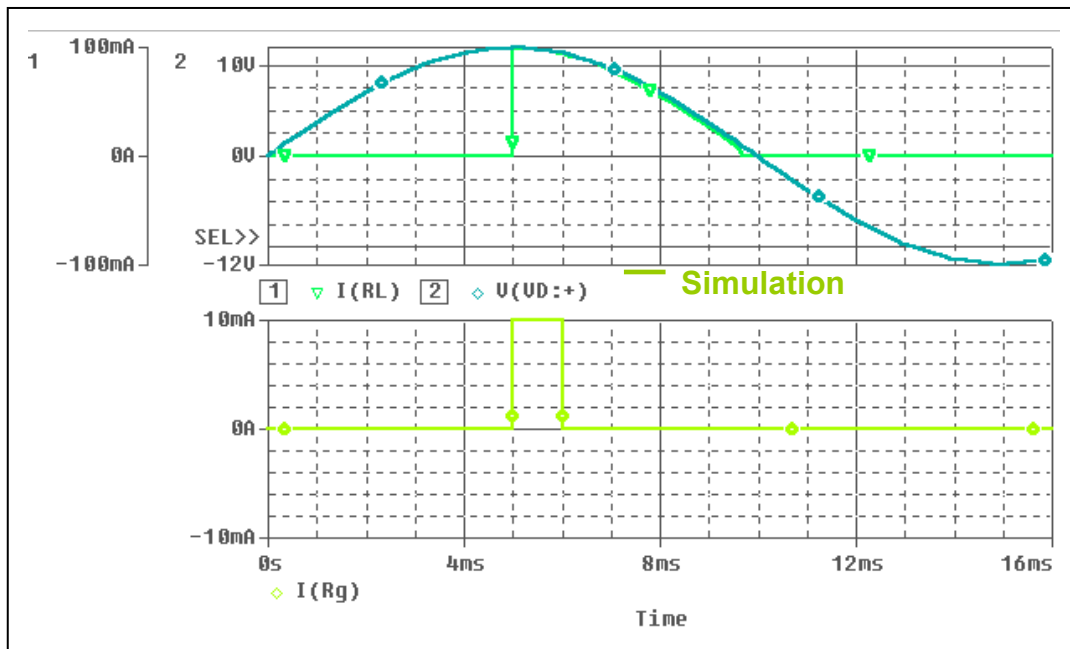
At ITM=23A	Measurement	Simulation	% Error
VTM(V)	1.4	1.4214	1.52857

Holding Characteristic (IH)

Evaluation Circuit



Simulation result

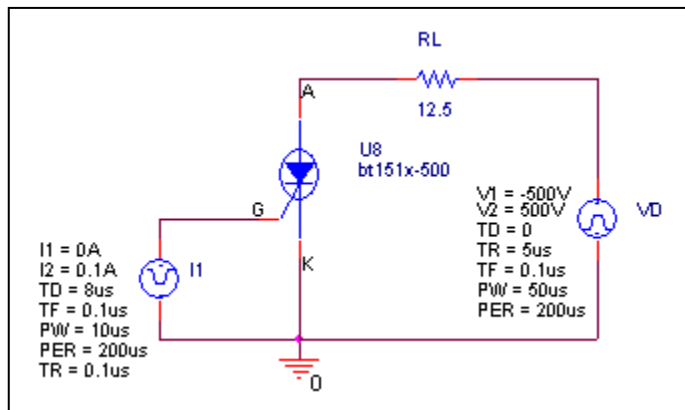


Comparison Table

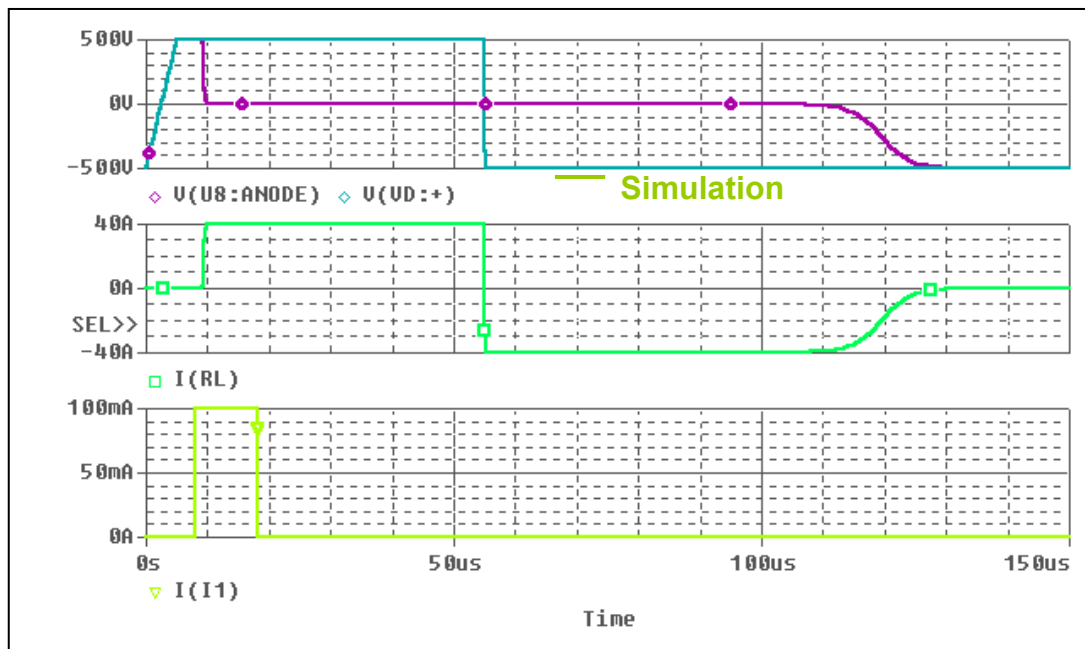
VD=12V	Measurement	Simulation	% Error
IH(mA)	7	6.9798	-0.28857

Switching Time Characteristic

Evaluation Circuit



Simulation result



Comparison Table

	Measurement	Simulation	%Error
Ton(us)	2	2.0185	0.92500
Toff(us)	70	69.640	-0.51429